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between pinned layer 44 and free layer 48. Permanent magnets 50A and 50B are each positioned adjacent to pinned layer 44 and to a corresponding side of spacer layer 46 and free layer 48. Contacts 52A and 52B are positioned adjacent to free layer 48 and pinning layer 42, respectively.

The magnetization of pinned layer 44 is fixed while the magnetization of free layer 48 rotates freely in response to an external magnetic field emanating from a magnetic medium. The magnetization of pinned layer 44 is pinned by exchange coupling pinning layer 42 with pinned layer 44. The resistance of GMR stack 40 varies as a function of an angle that is formed between the magnetization of free layer 48 and the magnetization of pinned layer 44. The GMR signal produced by GMR stack 40 is generated by a sense current flowing perpendicularly through the layers of GMR stack 40.

Pinning layer 42 and pinned layer 44 each have a significantly greater number of structural grains (and thus a significantly greater lateral size) than free layer 48. The lateral size of free layer 48 is typically about 4 square structural grains to about 9 square structural grains. The lateral size of pinning layer 42 and pinned layer 44 is typically about 64 square structural grains to about 100 square structural grains. This allows GMR stack 40 to exhibit a significantly lower fluctuation of magnetization than if pinning layer 42 and pinned layer 44 each had a similar lateral size to free layer 48. In addition, because free layer 48 has a significantly smaller lateral size than pinning layer 42 and pinned layer 44, GMR stack 40 exhibits a significantly higher spatial resolution than if free layer 48 had a similar lateral size to pinning layer 42 and pinned layer 44.

GMR stack 40 would also function similarly if permanent magnets 50A and 50B were replaced by antiferromagnetic exchange tabs coupled to the outer regions of free layer 48.

FIG. 4B is a layer diagram of a fifth embodiment of a tunneling magnetoresistive (TMR) stack 40' of the present invention. TMR stack 40' is similar to GMR stack 40 of FIG. 4A. Barrier layer 46', however, differs from spacer layer 46 of GMR stack 40 in that barrier layer 46' is a nonmagnetic insulating material (instead of a nonmagnetic conducting material). The TMR signal produced by TMR stack 40' is generated by a sense current flowing perpendicularly through the layers of TMR stack 40'.

For both GMR stack 40 and TMR stack 40', permanent magnets 50A and 50B can be separated from pinned layer 44 using techniques similar to those in FIGS. 3B and 3C.

Although the present invention has been described with reference to preferred embodiments, workers skilled in the art will recognize that changes may be made in form and detail without departing from the spirit and scope of the invention.

What is claimed is:

1. A read sensor for use in a magnetic read head, the read sensor comprising:

a magnetoresistive stack having a plurality of layers; and means for decreasing a fluctuation of magnetization in the read sensor without decreasing a spatial resolution of the read sensor, the means for decreasing a fluctuation of magnetization in the read sensor including a ferromagnetic pinned layer and an antiferromagnetic pinning layer each having a greater lateral size than a ferromagnetic free layer and each having a greater dimension extending perpendicular from an air bearing surface of the read sensor than the ferromagnetic free layer.

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2. The read sensor of claim 1 wherein the means for decreasing a fluctuation of magnetization in the read sensor increases a pinning field direction dispersion in an antiferromagnetic pinning layer.

3. The read sensor of claim 1 wherein the means for decreasing a fluctuation of magnetization in the read sensor increases a number of structural grains in an antiferromagnetic pinning layer.

4. The read sensor of claim 1 wherein the pinned layer is a synthetic antiferromagnet.

5. The read sensor of claim 1 wherein the magnetoresistive stack is a giant magnetoresistive (GMR) stack configured to operate in a current-in-plane (CIP) mode wherein a sense current flows substantially parallel to a longitudinal plane of the layers of the stack.

6. The read sensor of claim 1 wherein the magnetoresistive stack is a giant magnetoresistive (GMR) stack configured to operate in a current-perpendicular-to-plane (CPP) mode wherein a sense current flows substantially perpendicular to a longitudinal plane of the layers of the stack.

7. The read sensor of claim 1 wherein the magnetoresistive stack is a tunneling magnetoresistive (TMR) stack configured to operate in a current-perpendicular-to-plane (CPP) mode wherein a sense current flows substantially perpendicular to a longitudinal plane of the layers of the stack.

8. A read sensor for use in a magnetic read head, the read sensor having a plurality of layers including:

a ferromagnetic free layer having a rotatable magnetic moment;

a ferromagnetic pinned layer having a fixed magnetic moment; and

an antiferromagnetic pinning layer positioned adjacent to the pinned layer, wherein the pinned layer and the pinning layer each have a greater lateral size than the free layer and have a greater dimension extending perpendicular from an air bearing surface of the read sensor than the free layer.

9. The read sensor of claim 8 wherein the pinned layer is a synthetic antiferromagnet.

10. The read sensor of claim 8 wherein the read sensor further includes a nonmagnetic spacer layer positioned between the free layer and the pinned layer.

11. The read sensor of claim 10 wherein the read sensor is a giant magnetoresistive (GMR) stack configured to operate in a current-in-plane (CIP) mode wherein a sense current flows substantially parallel to a longitudinal plane of the pinned layer.

12. The read sensor of claim 10 wherein the read sensor is a giant magnetoresistive (GMR) stack configured to operate in a current-perpendicular-to-plane (CPP) mode wherein a sense current flows substantially perpendicular to a longitudinal plane of the pinned layer.

13. The read sensor of claim 8 wherein the read sensor further includes a barrier layer positioned between the free layer and the pinned layer.

14. The read sensor of claim 13 wherein the read sensor is a tunneling magnetoresistive (TMR) stack configured to operate in a current-perpendicular-to-plane (CPP) mode wherein a sense current flows substantially perpendicular to a longitudinal plane of the pinned layer.

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